

<b>Notice of References Cited</b>	Application/Control No. 10/823,487	Applicant(s)/Patent Under Reexamination KOJIMA ET AL.	
	Examiner Martin J. Angebranndt	Art Unit 1756	Page 1 of 2

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	Examiner Martin J. Angebrannt	Art Unit 1756	Page 2 of 2

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	K	US-			
	L	US-			
	M	US-			

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